



P-Channel 8-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
	0.040 at V _{GS} = - 4.5 V	- 4.1			
- 8	0.060 at V _{GS} = - 2.5 V	- 3.4	7.8 nC		
	0.088 at V _{GS} = - 1.8 V	- 2.0			

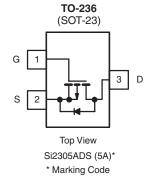
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

ROHS COMPLIANT HALOGEN FREE Available

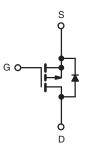
APPLICATIONS

- Load Switch
- DC/DC Converter



Ordering Information: Si2305ADS-T1-E3 (Lead (Pb)-free)

Si2305ADS-T1-GE3 (Lead (Pb)-free and Halogen-free)



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	$_{A}$ = 25 °C, unless othe	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 8	V		
Gate-Source Voltage		V _{GS}	± 8	V	
	T _C = 25 °C		- 5.4		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		- 4.3		
Continuous Dialit Current (1) = 150 °C)	T _A = 25 °C	I _D	- 4.1 ^{a, b}		
	T _A = 70 °C		- 3.3 ^{a, b}	A	
Pulsed Drain Current		I _{DM}	- 10		
Continuous Course Dunin Diada Courset	T _C = 25 °C	l _a	- 1.4		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 0.8 ^{a, b}		
	T _C = 25 °C		1.7		
Maximum Davier Dissipation	T _C = 70 °C	D.	1.1	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	0.96 ^{a, b}	VV	
	T _A = 70 °C		0.62 ^{a, b}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature)			260		

Notes:

a. Surface Mounted on 1" x 1" FR4 board.

b. t = 10 s.

Si2305ADS

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THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	100	130	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75		

Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. Maximum under Steady State conditions is 175 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 8			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$ $I_D = -250 \mu A$			- 55		m)//°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η = - 250 μΑ		2.1		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.45		- 0.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zarra Oata Waltana Daria Oarrant	I _{DSS}	V _{DS} = - 8 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = - 8 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 5			Α	
	, ,	V _{GS} = - 4.5 V, I _D = - 4.1 A		0.032	0.040	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 3.4 A		0.048	0.060		
		V _{GS} = - 1.8 V, I _D = - 2.0 A		0.070	0.088		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 4.1 A		8		S	
Dynamic ^b							
Input Capacitance	C _{iss}			740		pF	
Output Capacitance	C _{oss}	$V_{DS} = -4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		290			
Reverse Transfer Capacitance	C _{rss}			190			
T. 10 1 01	Q _g Q _{gs} Q _{gd}	$V_{DS} = -4 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4.1 \text{ A}$		7.8	15	nC	
Total Gate Charge		V _{DS} = - 4 V, V _{GS} = - 2.5 V, I _D = - 4.1 A		4.5	9		
Gate-Source Charge				1.2			
Gate-Drain Charge				1.6			
Gate Resistance	R_{g}	f = 1 MHz	1.4	7	14	Ω	
Turn-On Delay Time	t _{d(on)}			13	20		
Rise Time	t _r	V_{DD} = - 4 V, R_L = 1.2 Ω		35	53	1	
Turn-Off DelayTime	t _{d(off)}	$I_{D} \cong -3.3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_{g} = 1 \Omega$		32	48	1	
Fall Time	t _f			10	20	1	
Turn-On Delay Time	t _{d(on)}			5	10	ns	
Rise Time	t _r	$V_{DD} = -4 \text{ V}, R_{L} = 1.2 \Omega$		11	17		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -3.3 \text{ A}, V_{GEN} = -8 \text{ V}, R_g = 1 \Omega$		22	33		
Fall Time	t _f	1		16	24	1	
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 1.4		
Pulse Diode Forward Current ^a	I _{SM}	-			- 10	Α	
Body Diode Voltage	V _{SD}	I _F = - 3.3 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			33	50	ns	
Body Diode Reverse Recovery Charge Q _{rr}				14	21	nC	
Reverse Recovery Fall Time	t _a	$I_F = -3.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$		14		1	
Reverse Recovery Rise Time	t _b	1		19		ns	

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

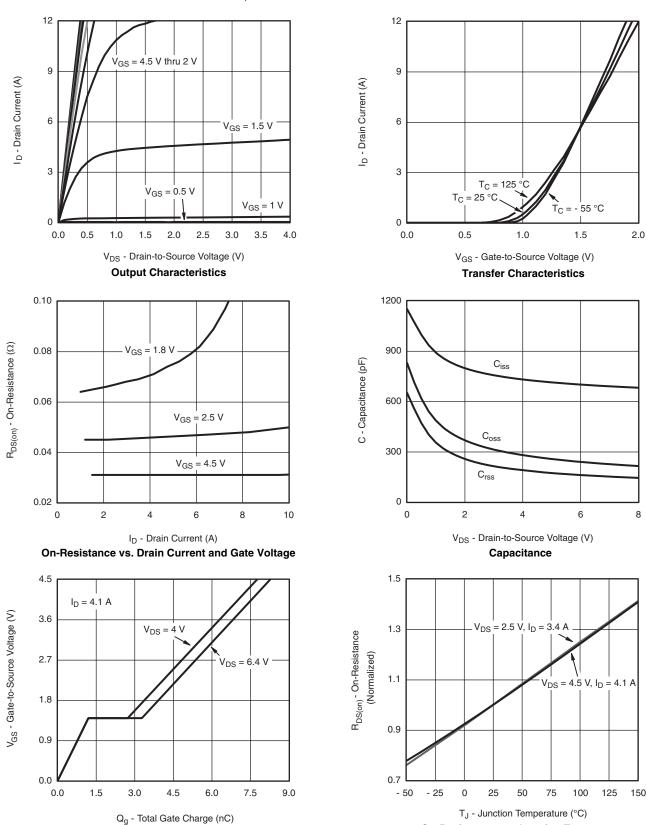
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.







TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



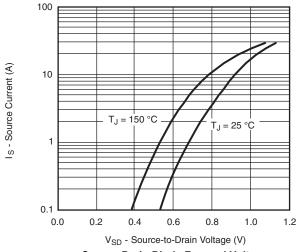
Gate Charge

On-Resistance vs. Junction Temperature

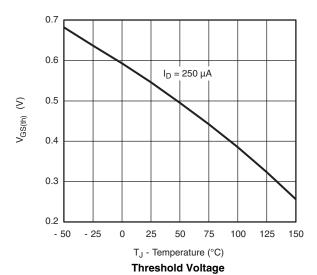
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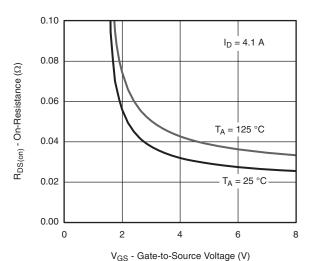
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

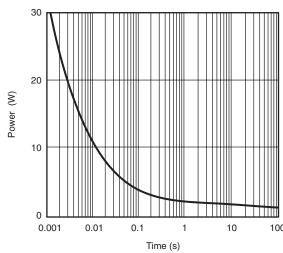


Source-Drain Diode Forward Voltage

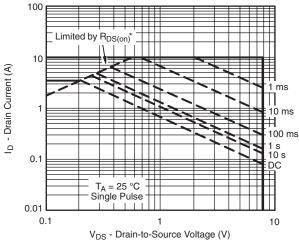




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

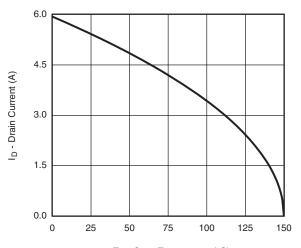


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

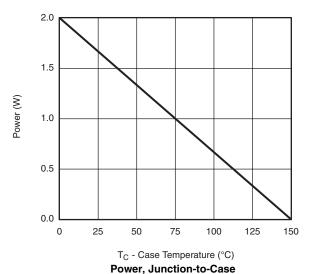


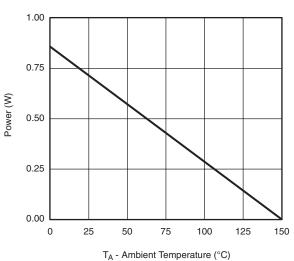
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





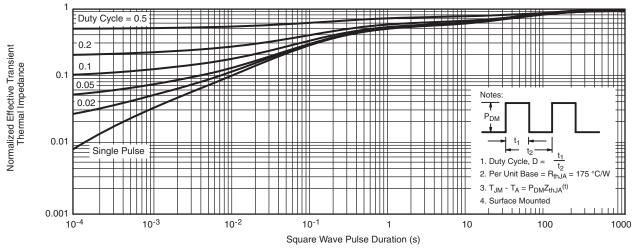
Power, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

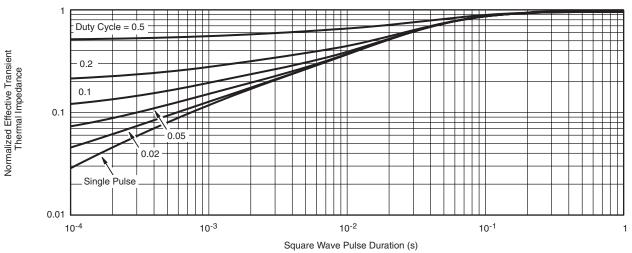
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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